

## STD15N50M2AG

# Automotive-grade N-channel 500 V, 0.336 Ω typ., 10 A MDmesh™ M2 Power MOSFET in a DPAK package

Datasheet - production data

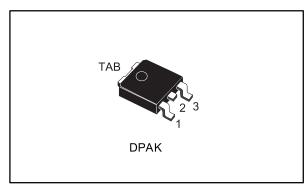
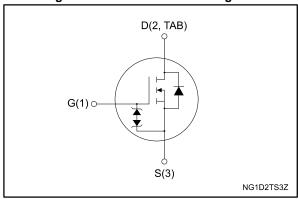


Figure 1: Internal schematic diagram



## **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>	Ртот
STD15N50M2AG	500 V	0.380 Ω	10 A	85 W

- Designed for automotive applications and AEC-Q101 qualified
- Extremely low gate charge
- Excellent output capacitance (Coss) profile
- 100% avalanche tested
- Zener-protected

## **Applications**

Switching applications

## **Description**

This device is an N-channel Power MOSFET developed using MDmesh™ M2 technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance and optimized switching characteristics, rendering it suitable for the most demanding high efficiency converters.

Table 1: Device summary

Order code	Marking	Package	Packing
STD15N50M2AG	15N50M2	DPAK	Tape and reel

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STD15N50M2AG Electrical ratings

# 1 Electrical ratings

**Table 2: Absolute maximum ratings** 

Symbol	Parameter	Value	Unit
V <sub>G</sub> s	Gate-source voltage	±30	V
l <sub>=</sub>	Drain current (continuous) at T <sub>case</sub> = 25 °C	10	۸
I <sub>D</sub>	Drain current (continuous) at T <sub>case</sub> = 100 °C	7	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	40	А
P <sub>TOT</sub>	Total dissipation at T <sub>case</sub> = 25 °C	85	W
dv/dt <sup>(2)</sup>	Peak diode recovery voltage slope	10	V/ns
dv/dt <sup>(3)</sup>	MOSFET dv/dt ruggedness	25	V/IIS
T <sub>stg</sub>	Storage temperature range	-55 to 150	°C
Tj	Operating junction temperature range	-55 (0 150	

#### Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max.	1.47	0000
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction-pcb max.	50	°C/W

### Notes:

**Table 4: Avalanche characteristics** 

Symbol	Parameter	Value	Unit
I <sub>AR</sub> <sup>(1)</sup>	Avalanche current, repetitive or not repetitive	3.5	Α
E <sub>AS</sub> <sup>(2)</sup>	Single pulse avalanche energy	200	mJ

## Notes:

<sup>&</sup>lt;sup>(1)</sup> Pulse width is limited by safe operating area.

 $<sup>^{(2)}</sup>$   $I_{SD} \leq$  10 A, di/dt=800 A/µs;  $V_{DS}$  peak <  $V_{(BR)DSS}, V_{DD}$  = 80%  $V_{(BR)DSS}$ 

 $<sup>^{(3)}</sup>$  V<sub>DS</sub>  $\leq 400$  V.

<sup>&</sup>lt;sup>(1)</sup>When mounted on a 1 inch² FR-4, 2 Oz copper board

 $<sup>^{(1)}</sup>$  pulse width limited by  $T_{jmax}$ 

 $<sup>^{(2)}</sup>$  starting  $T_j$  = 25 °C,  $I_D$  =  $I_{AR},\,V_{DD}$  = 50 V.

## 2 Electrical characteristics

(T<sub>case</sub> = 25 °C unless otherwise specified)

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	500			>
Zono moto velto no ducio		$V_{GS} = 0 \text{ V}, V_{DS} = 500 \text{ V}$			1	
IDSS	Zero gate voltage drain current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 500 V, T <sub>case</sub> = 125 °C			100	μΑ
Igss	Gate-body leakage current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±25 V			±5	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A		0.336	0.380	Ω

Table 6: Dynamic

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	530	-	
Coss	Output capacitance	V <sub>DS</sub> = 100 V, f = 1 MHz,	-	33	-	pF
Crss	Reverse transfer capacitance	Ves = 0 V	-	0.8	-	ρ.
Coss eq. (1)	Equivalent output capacitance	V <sub>DS</sub> = 0 to 400 V, V <sub>GS</sub> = 0 V	-	125	-	pF
Rg	Intrinsic gate resistance	f = 1 MHz, I <sub>D</sub> = 0 A	-	6.9	-	Ω
Qg	Total gate charge	$V_{DD} = 400 \text{ V}, I_D = 9 \text{ A},$	-	13	-	
$Q_{gs}$	Gate-source charge	V <sub>GS</sub> = 10 V (see Figure 15: "Test circuit for gate charge	-	2.8	-	nC
$Q_{gd}$	Gate-drain charge	behavior")	-	5.1	-	

#### **Notes**

**Table 7: Switching times** 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 4.5 A	ı	10	ı	
tr	Rise time	$R_G = 4.7 \Omega$ , $V_{GS} = 10 V$ (see Figure 14: "Test circuit for	-	3.2	-	
t <sub>d(off)</sub>	Turn-off delay time	resistive load switching times"	-	84	-	ns
t <sub>f</sub>	Fall time	and Figure 19: "Switching time waveform")	-	8.8	1	

 $<sup>^{(1)}</sup>$  Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDs increases from 0 to 80% VDss.

2.7

17.5

μC

Α

**Symbol Parameter Test conditions** Min. Тур. Max. Unit Source-drain current 10 Α IsD Source-drain current I<sub>SDM</sub><sup>(1)</sup> Α 40 (pulsed)  $V_{SD}^{(2)}$ Forward on voltage  $V_{GS} = 0 V$ ,  $I_{SD} = 10 A$ 1.6 V  $I_{SD} = 9 A$ ,  $di/dt = 100 A/\mu s$ , \_ 230  $t_{\text{rr}} \\$ Reverse recovery time ns V<sub>DD</sub> = 100 V (see *Figure 16*:  $Q_{rr}$ Reverse recovery charge 2 μC "Test circuit for inductive load switching and diode recovery  $I_{RRM}$ Reverse recovery current 17.4 Α times")  $I_{SD} = 9 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$  $t_{rr}$ Reverse recovery time \_ 310 ns

 $V_{DD} = 100 \text{ V}, T_j = 150 ^{\circ}\text{C}$  (see

Figure 16: "Test circuit for inductive load switching and

diode recovery times")

Table 8: Source-drain diode

#### Notes:

 $Q_{rr} \\$ 

 $I_{RRM}$ 

Reverse recovery charge

Reverse recovery current

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage	$I_{GS} = \pm 250 \ \mu\text{A}, \ I_{D} = 0 \ \text{A}$	±30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



<sup>&</sup>lt;sup>(1)</sup> Pulse width is limited by safe operating area.

<sup>&</sup>lt;sup>(2)</sup> Pulse test: pulse duration = 300  $\mu$ s, duty cycle 1.5%.

# 2.1 Electrical characteristics (curves)

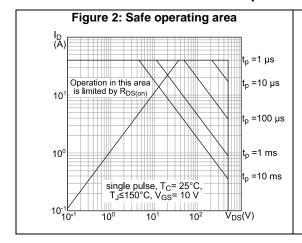


Figure 3: Thermal impedance  $K = \frac{6000460}{10^{-1}}$   $\frac{\delta = 0.5}{\delta = 0.2}$   $\frac{\delta = 0.2}{\delta = 0.01}$   $\frac{\delta = 0.05}{\delta = 0.01}$   $\frac{\zeta_{\text{th}} = K^* R_{\text{th}-c}}{\delta = t_{\text{p}}/T}$   $\frac{\zeta_{\text{th}}}{\delta = 0.01}$   $\frac{\delta = 0.01}{\delta = 0.01}$ Single pulse  $\frac{10^{-3}}{10^{-5}}$   $\frac{10^{-3}}{10^{-5}}$   $\frac{10^{-4}}{10^{-3}}$   $\frac{10^{-2}}{10^{-1}}$   $\frac{10^{-1}}{t_{\text{p}}}(s)$ 

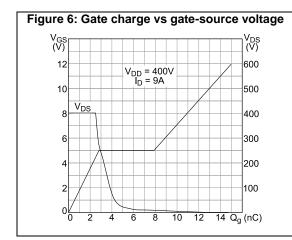
Figure 4: Output characteristics

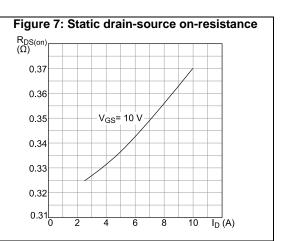
1<sub>D</sub>(A)
20
V<sub>GS</sub>=8,9,10V
V<sub>GS</sub>=7V
V<sub>GS</sub>=6V

12
V<sub>GS</sub>=5V
8
4
0
0
4
8
12
16
V<sub>GS</sub>=4V
0
0
0
4
8
12
16
V<sub>DS</sub>(V)

Figure 5: Transfer characteristics

ID
(A)
20
16
12
8
4
0
0
2
4
6
8
VGS(V)





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STD15N50M2AG Electrical characteristics

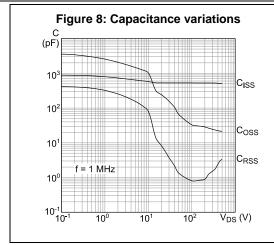


Figure 9: Normalized gate threshold voltage vs temperature

V<sub>GS(th)</sub>
(norm.)

1.1

1.0

0.9

0.8

0.7

0.6

-75

-25

25

75

125

T<sub>J</sub>(°C)

Figure 10: Normalized on-resistance vs temperature

RDS(on) (norm.)

2.2

1.8

1.4

1.0

0.6

0.5

75

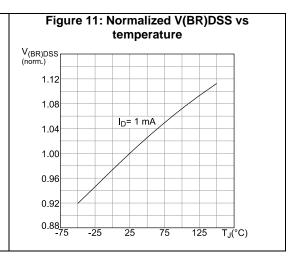
-25

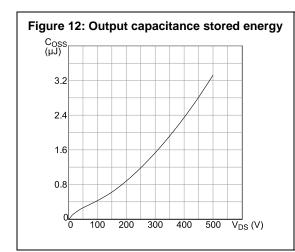
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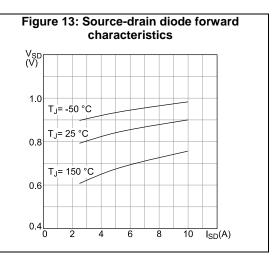
75

125

TJ(°C)

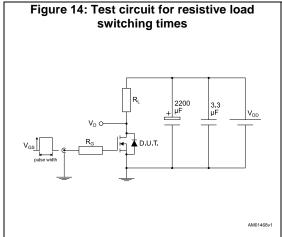






Test circuits STD15N50M2AG

## 3 Test circuits



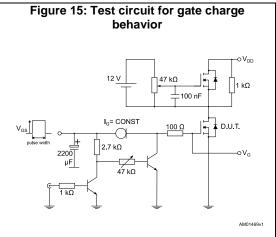
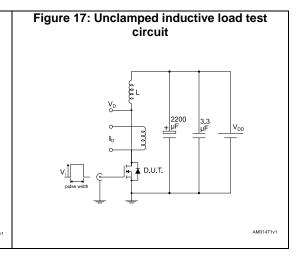
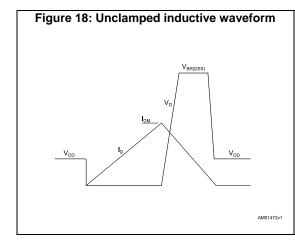
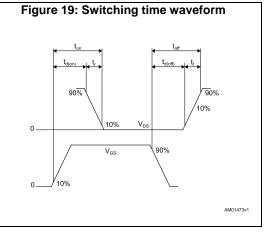


Figure 16: Test circuit for inductive load switching and diode recovery times







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# 4 Package information

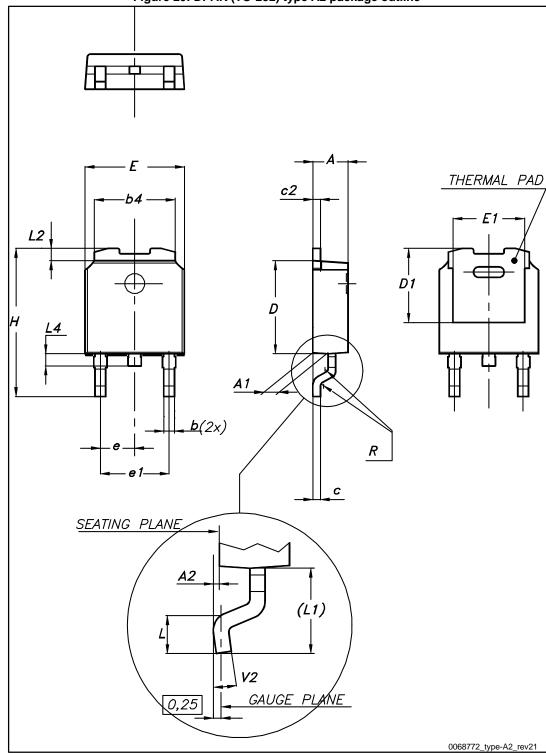
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.



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# 4.1 DPAK (TO-252) type A2 package information

Figure 20: DPAK (TO-252) type A2 package outline



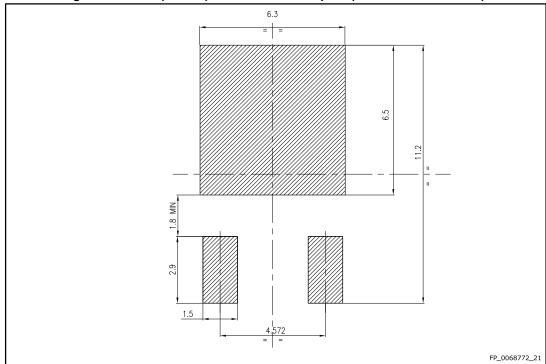
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Table 10: DPAK (TO-252) type A2 mechanical data

	1400 101 21 741 (10 20	-, typo /t= illoonailloai a	
Di		mm	
Dim.	Min.	Тур.	Max.
А	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
С	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1	4.95	5.10	5.25
E	6.40		6.60
E1	5.10	5.20	5.30
е	2.16	2.28	2.40
e1	4.40		4.60
Н	9.35		10.10
L	1.00		1.50
L1	2.60	2.80	3.00
L2	0.65	0.80	0.95
L4	0.60		1.00
R		0.20	
V2	0°		8°



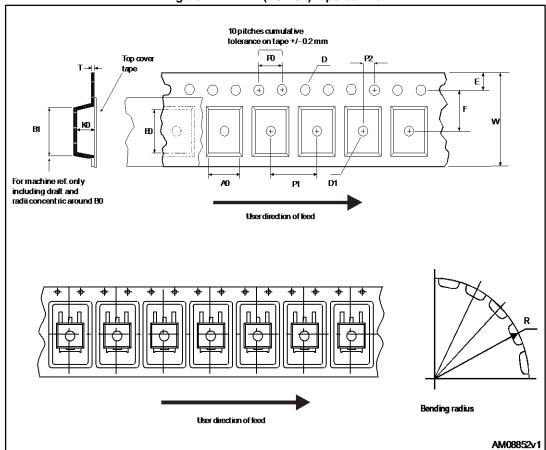
Figure 21: DPAK (TO-252) recommended footprint (dimensions are in mm)



STD15N50M2AG Package information

# 4.2 DPAK (TO-252) packing information

Figure 22: DPAK (TO-252) tape outline



40mm min. access hole at slot location

Tape slot in core for tape start 2.5mm min.width

G measured at hub

Figure 23: DPAK (TO-252) reel outline

Table 11: DPAK (TO-252) tape and reel mechanical data

AM06038v1

Таре				Reel	
Dim.	n	nm	Dim.	n	nm
DIM.	Min.	Max.	Jim.	Min.	Max.
A0	6.8	7	Α		330
В0	10.4	10.6	В	1.5	
B1		12.1	С	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
Е	1.65	1.85	N	50	
F	7.4	7.6	Т		22.4
K0	2.55	2.75			
P0	3.9	4.1	Bas	se qty.	2500
P1	7.9	8.1	Bu	k qty.	2500
P2	1.9	2.1			
R	40				
Т	0.25	0.35			
W	15.7	16.3			

STD15N50M2AG Revision history

# 5 Revision history

Table 12: Document revision history

Date	Revision	Changes
13-Apr-2015	1	First release.
07-May-2016	2	Minor text edits  Document status promoted to production data  Updated Section 1: "Electrical ratings"  Updated Section 2: "Electrical characteristics"  Updated Section 2.1: "Electrical characteristics (curves)"  Updated Section 4.1: "DPAK (TO-252) type A2 package information"



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